

On-the-fly dynamics simulation of dissociative electron attachment to chloroethane

F Kossoski, M Barbatti

▶ To cite this version:

F Kossoski, M Barbatti. On-the-fly dynamics simulation of dissociative electron attachment to chloroethane. Journal of Physics: Conference Series, 2020, 1412 (17), pp.172010. 10.1088/1742-6596/1412/17/172010. hal-03812068

HAL Id: hal-03812068 https://amu.hal.science/hal-03812068

Submitted on 12 Oct 2022

HAL is a multi-disciplinary open access archive for the deposit and dissemination of scientific research documents, whether they are published or not. The documents may come from teaching and research institutions in France or abroad, or from public or private research centers. L'archive ouverte pluridisciplinaire **HAL**, est destinée au dépôt et à la diffusion de documents scientifiques de niveau recherche, publiés ou non, émanant des établissements d'enseignement et de recherche français ou étrangers, des laboratoires publics ou privés.



Distributed under a Creative Commons Attribution 4.0 International License

PAPER • OPEN ACCESS

On-the-fly dynamics simulation of dissociative electron attachment to chloroethane

To cite this article: F Kossoski and M Barbatti 2020 J. Phys.: Conf. Ser. 1412 172010

View the article online for updates and enhancements.

You may also like

- <u>Ion-induced secondary electron emission</u> from metal surfaces M Pamperin, F X Bronold and H Fehske
- Negative ion adsorption by the ion source surface as a factor influencing ion lifetime measurements
 V G Lukin and O G Khvostenko
- <u>Electron attachment properties of $c-C_{4}F_{8}O$ </u>
- in different environments A Chachereau, J Fedor, R Janeková et al.

Journal of Physics: Conference Series

On-the-fly dynamics simulation of dissociative electron attachment to chloroethane

F Kossoski¹* and M Barbatti¹

¹ Aix Marseille Univ, CNRS, ICR, Marseille, France

Synopsis We present a novel theoretical approach for describing dissociative electron attachment. It is is based on classically propagating the nuclei on the potential surface of the resonant anion, which is described by bound state methods, while electron autodetachment is taken into account with an ad-hoc model built from scattering calculation results. As a first application, we considered the electron induced dissociation of chloroethane. Comparison to experimental data is very encouraging. The simulations reveal further details on the underlying dynamics of the dissociation.

Electron capture by a molecular target can give rise to a resonant anion, which decays either by detachment of the excess electron or by dissociation. The later process, dissociative electron attachment (DEA), plays key roles in radiationinduced biological damage, current and nascent technological applications, interstellar medium, among others [1].

Existing theoretical descriptions of DEA usually rely on propagating the nuclear wavepacket on complex potential energy surfaces, which are built from computationally demanding scattering calculations [2]. Despite being successful, most applications are limited to small molecules [3] or to models of reduced dimensionality [4]. Molecular dynamics simulations for the later stages of DEA are sometimes employed [5]. after the anion becomes stable against autoionization. However, we are not aware of any current and feasible method capable of describing DEA to systems with more than a few vibrational degrees of freedom while considering for the finite lifetimes of the resonances.

We propose an alternative approach to the problem, where the resonant anions are described with bound state methods, nuclei are propagated classically, and electron autodetachment is accounted for by a model that requires few scattering calculations. This approach is benchmarked against quantum wavepacket propagation on model potential energy curves. Different curve steepness, magnitudes of the imaginary component and reduced mass were considered. We found a very similar overall behavior for the cases considered.

The very first application of the proposed ap-

proach concerns DEA to chloroethane, where the chloride ion is abstracted via formation of a σ^* resonance [6]. An ensemble of classical trajectories were propagated on potential surfaces computed on-the-fly at the Multireference configuration interaction with singles and doubles level of theory. The σ^* character of the anion state was confirmed with electron scattering calculations performed with the Schwinger multichannel method [7]. These later calculations further provided resonance widths, which were employed for modeling the autodetachment probability during the dynamics propagation.

The computed DEA cross section showed the same experimentally observed [6] displacement from the vertical resonance energy ($\sim 2.5 \text{ eV}$) to the maximum ion yield energy ($\sim 1.5 \text{ eV}$), as well as comparable magnitudes. This supports the adopted autodetachment model and the overall proposed strategy to the problem. We have also addressed the dependence of the DEA cross section on several components of the simulation: the accuracy of the autodetachment model, of the electronic structure and scattering calculations. Finally, the dynamics simulation provides a detailed time-dependent picture on the relaxation of the resonant anion.

References

- [1] Arumainayagam C et al 2010 Surf. Sci. Rep. 65 1
- [2] Gertitschke P L et al 1993 Phys. Rev. A 47 1003
- [3] Haxton D et al 2007 Phys. Rev. A 75 12711
- [4] Gallup G A et al 2011 Phys. Rev. A 83 12706
- [5] Feng W et al 2015 J. Phys. Chem. A 119 1838
- [6] Aflatooni K et al 2000 J. Chem. Phys. 113 1455
- [7] da Costa R et al 2015 Eur. Phys. J. D 69 159



Content from this work may be used under the terms of the Creative Commons Attribution 3.0 licence. Any further distribution of this work must maintain attribution to the author(s) and the title of the work, journal citation and DOI. Published under licence by IOP Publishing Ltd 1

^{*}E-mail: fabris.kossoski@univ-amu.fr